MOS INTEGRATED CIRCUIT μ PD78F9026A

8-BIT SINGLE-CHIP MICROCONTROLLER

DESCRIPTION

The µPD78F9026A is a µPD789026 Subseries product (compact general-purpose devices) of the 78K/0S Series.

The μ PD78F9026A has flash memory in place of the internal ROM of the μ PD789022, 789024, 789025, and 789026.

Since the data can be written to or erased from the flash memory of the μ PD78F9026A with the microcontroller mounted on a printed circuit board, it is ideal for applications involving the evaluation of the systems in the development stage, small-scale production of many different products, and rapid development and time-to-market of a new product.

Detailed function descriptions are provided in the following user's manuals. Be sure to read them before designing.

μPD789026 Subseries User's Manual: U11919E 78K/0S Series User's Manual — Instruction: U11047E

FEATURES

- Pin compatible with mask ROM version (except VPP pin)
- Flash memory: 16 Kbytes
- Internal high-speed RAM: 512 bytes
- Minimum instruction execution time can be changed from high-speed (0.4 μs) to low-speed (1.6 μs) (@ 5.0-MHz operation with system clock)
- I/O ports: 34
- Serial interface: 1 channel
- 3-wire serial I/O mode/UART mode can be selected
- Timer: 3 channels
 - 16-bit timer: 1 channel
 - 8-bit timer/event counter: 1 channel
 - Watchdog timer: 1 channel
- Power supply voltage: VDD = 1.8 to 5.5 V

APPLICATIONS

Compact household appliances, car accessories, air conditioners, games, etc.

ORDERING INFORMATION

Part Number	Package
μPD78F9026ACU	42-pin plastic shrink DIP (600 mils)
μ PD78F9026AGB-3BS-MTX	44-pin plastic QFP (10 \times 10 mm, resin thickness: 2.7 mm)
μPD78F9026AGB-8ES	44-pin plastic LQFP (10 \times 10 mm, resin thickness: 1.4 mm)

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78K/0S SERIES LINEUP

The products in the 78K/0S Series are listed below. The names enclosed in boxes are subseries names.



The major functional differences among the subseries are listed below.

	Function	ROM		Tir	ner		8-Bit	10-Bit	Serial Interface	I/O	Vdd MIN	Remark
Subserie	s Name	Capacity	8-bit	16-bit	Watch	WDT	A/D	A/D	Senai Internace	1/0	Value	Remark
Small-scale	µPD789046	16 K	1 ch	1 ch	1 ch	1 ch	_	_	1 ch (UART:1 ch)	34	1.8 V	_
package,	µPD789026	4 K to 16 K										
general- purpose	μPD789014	2Kto4K	2 ch	_						22	-	
Small- scale package, general- purpose + A/D	μPD789217AY	16 K to 24 K	3 ch	1 ch	1 ch	1 ch	_	8 ch	2 ch (UART: 1 ch SMB: 1 ch	31	1.8 V	RC oscillation version, internal EEPROM Internal
	μΡΟΙΟ919ΙΑΙ											EEPROM
	μPD789177								1 ch (UART: 1 ch)			
	μPD789167						8 ch	_				
	μPD789156	8 K to 16 K	1 ch		_		_	4 ch		20		Internal
	μPD789146						4 ch					EEPROM
	μPD789134A	2Kto8K						4 ch				RC oscillation
	μPD789124A						4 ch	_				version
	μPD789114A						_	4 ch				
	µPD789104A						4 ch	_				
Inverter control	μPD789842	8 K to 16 K	3 ch	Note	1 ch	1 ch	8 ch	_	1 ch (UART: 1 ch)	30	4.0 V	—
LCD	µPD789830	24 K	1 ch	1 ch	1 ch	1 ch	_	_	1 ch (UART: 1 ch)	30	2.7 V	_
drive	μPD789417A	12 K to 24 K	3 ch					7 ch		43	1.8 V	
	μPD789407A						7 ch	_		25		
	μPD789457	16 K to 24 K	2 ch				_	4 ch	2 ch (UART: 1 ch)			RC oscillation
	μPD789447						4 ch	_				version
	μPD789437							4 ch				—
	μPD789427						4 ch	—				
	μPD789316	8 K to 16 K					—			23		RC oscillation version
	µPD789306											—
ASSP	μPD789800	8K	2 ch	1 ch	—	1 ch	_	—	2 ch (USB: 1 ch)	31	4.0 V	—
	μPD789840						4 ch		1 ch	29	2.8 V	
	μPD789861	4K		—			_		—	14	1.8 V	RC oscillation version
	μPD789860											—
IC card	μPD789810	6K	—	—	_	1 ch	_	—		1	2.7 V	Internal EEPROM

Note 10-bit timer: 1 channel

OVERVIEW OF FUNCTIONS

	Item	Function		
Internal memory Flash memory		16 Kbytes		
	High-speed RAM	512 bytes		
Minimum instruction	n execution time	0.4 μ s/1.6 μ s (@ 5.0-MHz operation with system clock)		
General-purpose re	egisters	8 bits \times 8 registers		
Instruction set		16-bit operationBit manipulation (set, reset, test), etc.		
I/O ports		Total: 34 • CMOS input/output: 34		
Serial interface		3-wire serial I/O mode/UART mode selectable: 1 channel		
Timer		 16-bit timer: 1 channel 8-bit timer/event counter: 1 channel Watchdog timer: 1 channel 		
Timer outputs		2		
Vectored interrupt	Maskable	Internal: 5, External: 4		
sources	Non-maskable	Internal: 1		
Power supply voltage		V _{DD} = 1.8 to 5.5 V		
Operating ambient temperature		T _A = -40 to +85°C		
Packages		 42-pin plastic shrink DIP (600 mils) 44-pin plastic QFP (10 × 10 mm, resin thickness 2.7 mm) 44-pin plastic LQFP (10 × 10 mm, resin thickness 1.4 mm) 		

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1. PIN CONFIGURATION (TOP VIEW)

 42-pin plastic shrink DIP (600 mils) μPD78F9026ACU



Caution Connect the VPP pin directly to Vss in normal operation mode.

- 44-pin plastic QFP (10 \times 10 mm, resin thickness 2.7 mm) $\mu \text{PD78F9026AGB-3BS-MTX}$
- 44-pin plastic LQFP (10 x 10 mm, resin thickness 1.4 mm) μ PD78F9026AGB-8ES



Caution Connect the VPP pin directly to Vss0 or Vss1 in normal operation mode.

ASCK:	Asynchronous Serial Clock	RxD:	Receive Data
CPT2:	Capture Trigger Input	SCK0:	Serial Clock
INTP0 to INTP2:	Interrupt from Peripherals	SI0:	Serial Input
KR0 to KR7:	Key Return	SO0:	Serial Output
NC:	Non-connection	TIO:	Timer Input
P00 to P07:	Port 0	TO0, TO2:	Timer Output
P10 to P17:	Port 1	TxD:	Transmit Data
P20 to P22:	Port 2	Vdd0, Vdd1:	Power Supply
P30 to P32:	Port 3	Vpp:	Programming Power Supply
P40 to P47:	Port 4	Vsso, Vss1:	Ground
P50 to P53:	Port 5	X1, X2:	Crystal
RESET :	Reset		

2. BLOCK DIAGRAM



3. PIN FUNCTIONS

3.1 Port Pins

Pin Name	I/O	Function	After Reset	Alternate Function
P00 to P07	I/O	Port 0 8-bit input/output port Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be specified by means of software. LEDs can be driven directly.	Input	
P10 to P17	I/O	Port 1 8-bit input/output port Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be specified by means of software. LEDs can be driven directly.	Input	_
P20	I/O	Port 2 3-bit input/output port	Input	ASCK/ SCK0
P21		Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be		TxD/SO0
P22		specified by means of software. LEDs can be driven directly.		RxD/SI0
P30	I/O	Port 3 3-bit input/output port	Input	INTP0
P31		Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be		INTP1
P32		specified by means of software. LEDs can be driven directly.		INTP2/CPT2
P40 to P47	I/O	Port 4 8-bit input/output port Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be specified by means of software. LEDs can be driven directly.	Input	KR0 to KR7
P50	I/O	Port 5 4-bit input/output port	Input	ТІ0/ТО0
P51		Input/output can be specified in 1-bit units. When used as an input port, an on-chip pull-up resistor can be		ТО2
P52, P53		specified by means of software. LEDs can be driven directly.		—

3.2 Non-Port Pins

Pin Name	I/O	Function	After Reset	Alternate Function
INTP0	Input	External interrupt input for which the valid edge (rising edge, falling	Input	P30
INTP1		edge, or both rising and falling edges) can be specified		P31
INTP2	-			P32/CPT2
SI0	Input	Serial interface serial data input	Input	P22/RxD
SO0	Output	Serial interface serial data output	Input	P21/TxD
SCK0	I/O	Serial interface serial clock input/output	Input	P20/ASCK
RxD	Input	Asynchronous serial interface serial data input	Input	P22/SI0
TxD	Output	Asynchronous serial interface serial data output	Input	P21/SO0
ASCK	Input	Asynchronous serial interface serial clock input	Input	P20/ SCK0
TI0	Input	External count clock input to 8-bit timer (TM00)	Input	P50/TO0
TO0	Output	8-bit timer (TM00) output	Input	P50/TI0
TO2	Output	16-bit timer (TM20) output	Input	P51
CPT2	Input	Capture edge input pin	Input	P32/INTP2
KR0 to KR7	Input	Key return signal detection pin	Input	P40 to P47
RESET	Input	System reset input	Input	_
X1	Input	Connecting crystal resonator for system clock oscillation	_	_
X2	_		_	_
Vddo	_	Positive power supply of ports		_
V _{DD1}	_	Positive power supply (except ports)	_	_
Vpp	_	Flash memory programming mode setting. High-voltage application for program write/verify. Connect directly to V _{SS0} or V _{SS1} in normal operation mode.	_	_
NC	_	Not internally connected. Leave open		—
Vsso	_	Ground potential of ports	_	_
Vss1	_	Ground potential (except ports)	_	_

3.3 Pin I/O Circuits and Recommended Connection of Unused Pins

The input/output circuit type of each pin and recommended connection of unused pins are shown in Table 3-1. For the input/output circuit configuration of each type, refer to Figure 3-1.

Pin Name	I/O Circuit Type	I/O	Recommended Connection of Unused Pins
P00 to P07	5-X	I/O	Input: Independently connect to VDD0 or VDD1, or VSS0 or VSS1 via
P10 to P17			a resistor.
P20/ASCK/ SCK0	8-J		Output: Leave open.
P21/TxD/SO0	5-X		
P22/RxD/SI0	8-J		
P30/INTP0			
P31/INTP1			
P32/INTP2/CPT2			
P40/KR0 to P47/KR7			
P50/TI0/TO0			
P51/TO2	5-X		
P52, P53			
RESET	2	Input	—
NC	_	_	Leave open.
Vpp			Connect directly to Vsso or Vsso.

Table 3-1. Types of Input/Output Circuits and Recommended Connection of Unused Pins



Figure 3-1. Pin Input/Output Circuits

4. MEMORY SPACE

The μ PD78F9026A can access up to 64 Kbytes of memory space. Figure 4-1 shows the memory map.



Figure 4-1. Memory Map

5. PROGRAMMING FLASH MEMORY

The program memory that is incorporated in the μ PD78F9026A is flash memory.

With flash memory, it is possible to write programs on-board. Writing is performed by connecting a dedicated flash programmer (Flashpro III, (Part No. FL-PR3, PG-FP3)) to the host machine and the target system.

Remark FL-PR3 is a product of Naito Densei Machida Mfg. Co., Ltd.

5.1 Selecting Communication Mode

Writing to flash memory is performed using the Flashpro III in a serial communication mode. Select one of the communication modes in Table 5-1. The selection of the communication mode is made by using the format shown in Figure 5-1. Each communication mode is selected using the number of VPP pulses shown in Table 5-1.

Communication Mode	Pins	VPP Pulses
3-wire serial I/O	SCK0/ASCK/P20 SO0/TxD/P21 SI0/RxD/P22	0
UART	TxD/SO0/P21 RxD/SI0/P22	8
Pseudo 3-wire serial I/O ^{Note}	P00 (Serial clock input) P01 (Serial data output) P02 (Serial data input)	12
	P40/KR0 (Serial clock input) P41/KR1 (Serial data output) P42/KR2 (Serial data input)	13

Table 5-1. List of Communication Mode

Note Serial transfer is carried out by controlling ports with software.

Caution Be sure to select a communication mode using the number of VPP pulses shown in Table 5-1.





5.2 Function of Flash Memory Programming

Operations such as writing to flash memory are performed by various command/data transmission and reception operations according to the selected communication mode. Table 5-2 shows the major functions of flash memory programming.

Function	Description
Batch delete	Deletes the entire memory contents
Batch blank check	Checks the deletion status of the entire memory
Data write	Performs a write operation to the flash memory based on the write start address and the number of data to be written (number of bytes).
Batch verify	Compares the entire memory contents with the input data.

Table 5-2. Major Function of Flash Memory Programming

5.3 Connecting Flashpro III

The connection of the Flashpro III and the μ PD78F9026A differs according to the communication mode (3-wire serial I/O, UART, and pseudo 3-wire serial I/O). The connections for each communication mode are shown in Figures 5-2, 5-3, and 5-4, respectively.



Figure 5-2. Connection of Flashpro III when Using 3-Wire Serial I/O Mode

Note n = 0, 1



Figure 5-3. Connection of Flashpro III when Using UART Mode





Note n = 0, 1

5.4 Example of Settings for Flashpro III (PG-FP3)

When writing to flash memory using Flashpro III (PG-FP3), make the following settings.

- 1. Load a parameter file.
- 2. Select the mode of serial communication and serial clock with a type command.
- 3. Make the settings according to the example of settings for PG-FP3 shown below.

Communication Mode	Example of Setti	ngs for PG-FP3	VPP Pulse NumberNote 1
3-wire serial I/O	COMM PORT	SIO-ch0	0
	CPU CLK	On Target Board	
		In Flashpro	
	On Target Board	4.1943 MHz	
	SIO CLK	1.0 MHz	
	In Flashpro	4.0 MHz	
	SIO CLK	1.0 MHz	
UART	COMM PORT	UART-ch0	8
	CPU CLK	On Target Board	
	On Target Board	4.1943 MHz	
	UART BPS	9600 bps ^{Note 2}	
Pseudo 3-wire serial I/O	COMM PORT	Port A	12
	CPU CLK	On Target Board	
		In Flashpro	
	On Target Board	4.1943 MHz	
	SIO CLK	1.0 MHz	
	In Flashpro	4.0 MHz	
	SIO CLK	1.0 MHz	
	COMM PORT	Port B	13
	CPU CLK	On Target Board	
		In Flashpro	
	On Target Board	4.1943 MHz	
	SIO CLK	1.0 MHz	
	In Flashpro	4.0 MHz	
	SIO CLK	1.0 MHz	

Table 5-3. Example of Settings for PG-FP3

- **Notes 1.** This is the number of VPP pulses that are supplied by the Flashpro III at serial communication initialization. The pins that will be used for communication are determined according to this number.
 - 2. Select one of 9600 bps, 19200 bps, 38400 bps, or 76800 bps.

Remark COMM PORT: Serial port selection

SIO CLK: Serial clock frequency selection

CPU CLK: Input CPU clock source selection

6. INSTRUCTION SET OVERVIEW

The instruction set for the μ PD78F9026A is listed later in this section.

6.1 Conventions

6.1.1 Operand identifiers and descriptions

The description made in the operand field of each instruction conforms to the operand identifier for the instructions listed below (the details conform to the assembly specifications). If more than one operand identifier is listed for an instruction, one is selected. Uppercase letters, #, !, \$, and [] are used to specify keywords, which must be written exactly as they appear. The meanings of these special characters are as follows:

- #: Immediate data specification
- \$: Relative address specification
- !: Absolute address specification
- []: Indirect address specification

Immediate data should be described using appropriate values or labels. The specification of values and labels must be accompanied by #, !, \$, or [].

Operand registers, expressed by the identifiers r or rp, can be described using both functional names (X, A, C, etc.) and absolute names (R0, R1, R2, and other names listed inside the parentheses in Table 6-1).

Identifier	Description
r	X (R0), A (R1), C (R2), B (R3), E (R4), D (R5), L (R6), H (R7)
rp sfr	AX (RP0), BC (RP1), DE (RP2), HL (RP3) Special function register symbol
saddr saddrp	FE20H to FF1FH: Immediate data or label FE20H to FF1FH: Immediate data or label (even addresses only)
addr16 addr5	0000H to FFFFH: Immediate data or label (only even address for 16-bit data transfer instructions) 0040H to 007FH: Immediate data or label (even addresses only)
word	16-bit immediate data or label
byte bit	8-bit immediate data or label 3-bit immediate data or label

Table 6-1. Operand Formats and Descriptions

6.1.2 Descriptions of the operation field

- A: A register (8-bit accumulator)
- X: X register
- B: B register
- C: C register
- D: D register
- E: E register
- H: H register
- L: L register
- AX: AX register pair (16-bit accumulator)
- BC: BC register pair
- DE: DE register pair
- HL: HL register pair
- PC: Program counter
- SP: Stack pointer
- PSW: Program status word
- CY: Carry flag
- AC: Auxiliary carry flag
- Z: Zero flag
- IE: Interrupt request enable flag
- NMIS: Flag to indicate that a non-maskable interrupt is being handled
- (): Contents of a memory location indicated by a parenthesized address or register name
- XH, XL: Upper and lower 8 bits of a 16-bit register
- ∧: Logical product (AND)
- v: Logical sum (OR)
- ∀: Exclusive OR
- -: Inverted data
- addr16: 16-bit immediate data or label
- jdisp8: Signed 8-bit data (displacement value)

6.1.3 Description of the flag operation field

(blank): No change

- 0: To be cleared to 0
- 1: To be set to 1
- ×: To be set or cleared according to the result
- R: To be restored to the previous value

6.2 Operations

Maamania	Operand		Durto	Cleak	Operation		Flag	1
Mnemonic	Operand		Byte	Clock	Operation	Z	AC	CY
MOV	r, #byte		3	6	$r \leftarrow byte$			
	saddr, #byte		3	6	$(saddr) \leftarrow byte$			
	sfr, #byte		3	6	$sfr \leftarrow byte$			
	A, r	Note 1	2	4	$A \leftarrow r$			
	r, A	Note 1	2	4	$r \leftarrow A$			
	A, saddr		2	4	$A \leftarrow (saddr)$			
	saddr, A		2	4	$(saddr) \leftarrow A$			
	A, sfr24 $A \leftarrow sfr$							
	sfr, A		2	4	$\begin{array}{cc} 4 & \text{sfr} \leftarrow A \\ \hline 8 & A \leftarrow (\text{addr16}) \end{array}$			
	A, !addr16		3	8				
	!addr16, A		3	8	$(addr16) \leftarrow A$			
	PSW, #byte		3	6	$PSW \leftarrow byte$	×	×	×
	A, PSW		2	4	$A \gets PSW$			
	PSW, A		2	4	$PSW \leftarrow A$	×	×	×
	A, [DE]		1	6	$A \leftarrow (DE)$			
	[DE], A		1	6	$(DE) \gets A$			
	A, [HL]		1	6	$A \leftarrow (HL)$			
	[HL], A		1	6	$(HL) \leftarrow A$			
	A, [HL + byte]		2	6	$A \leftarrow (HL + byte)$			
	[HL + byte], A		2	6	$(HL + byte) \leftarrow A$			
ХСН	A, X		1	4	$A \leftrightarrow X$			
	A, r	Note 2	2	6	$A \leftrightarrow r$			
	A, saddr		2	6	$A \leftrightarrow (saddr)$			
	A, sfr		2	6	$A \leftrightarrow (sfr)$			
	A, [DE]		1	8	$A \leftrightarrow (DE)$			
	A, [HL]		1	8	$A \leftrightarrow (HL)$			
	A, [HL + byte]		2	8	$A \leftrightarrow (HL + byte)$			
MOVW	rp, #word		3	6	$rp \leftarrow word$			
	AX, saddrp		2	6	$AX \gets (saddrp)$			
	saddrp, AX		2	8	$(saddrp) \leftarrow AX$			
	AX, rp	Note 3	1	4	AX ← rp			
	rp, AX	Note 3	1	4	$rp \leftarrow AX$			

Notes 1. Except when r = A.

- **2.** Except when r = A or X.
- **3.** Only when rp = BC, DE, or HL.
- **Remark** The instruction clock cycle is based on the CPU clock (fcPu), specified by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation		Flag	
					Z	AC	CY
XCHW	AX, rp	1	8	$AX \leftrightarrow rp$			
ADD	A, #byte	2	4	A, CY \leftarrow A + byte	×	×	×
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) + byte	×	×	×
	A, r	2	4	A, CY \leftarrow A + r	×	×	×
	A, saddr	2	4	A, CY \leftarrow A + (saddr)	×	×	×
	A, !addr16	3	8	A, CY \leftarrow A + (addr16)	×	×	×
	A, [HL]	1	6	A, CY \leftarrow A + (HL)	×	×	×
	A, [HL + byte]	2	6	A, CY \leftarrow A + (HL + byte)	×	×	×
ADDC	A, #byte	2	4	A, CY \leftarrow A + byte + CY	×	×	×
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) + byte + CY	×	×	×
	A, r	2	4	$A,CY \gets A + r + CY$	×	×	×
	A, saddr	2	4	A, CY \leftarrow A + (saddr) + CY	×	×	×
	A, !addr16	3	8	A, CY \leftarrow A + (addr16) + CY	×	×	×
	A, [HL]	1	6	$A,CY \gets A + (HL) + CY$	×	×	×
	A, [HL + byte]	2	6	A, CY \leftarrow A + (HL + byte) + CY	×	×	×
SUB	A, #byte	2	4	A, CY \leftarrow A – byte	×	×	×
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) – byte	×	×	×
	A, r	2	4	A, CY \leftarrow A – r	×	×	×
	A, saddr	2	4	A, CY \leftarrow A – (saddr)	×	×	×
	A, !addr16	3	8	A, CY \leftarrow A – (addr16)	×	×	×
	A, [HL]	1	6	A, CY \leftarrow A – (HL)	×	×	×
	A, [HL + byte]	2	6	A, CY \leftarrow A – (HL + byte)	×	×	×
SUBC	A, #byte	2	4	A, CY \leftarrow A – byte – CY	×	×	×
	saddr, #byte	3	6	(saddr), CY \leftarrow (saddr) – byte – CY	×	×	×
	A, r	2	4	A, CY \leftarrow A – r – CY	×	×	×
	A, saddr	2	4	A, CY \leftarrow A – (saddr) – CY	×	×	×
	A, !addr16	3	8	A, CY \leftarrow A – (addr16) – CY	×	×	×
	A, [HL]	1	6	A, CY \leftarrow A – (HL) – CY	×	×	×
	A, [HL + byte]	2	6	A, CY \leftarrow A – (HL + byte) – CY	×	×	×
AND	A, #byte	2	4	$A \leftarrow A \land byte$	×		
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) \land byte$	×		
	A, r	2	4	$A \leftarrow A \land r$	×		
	A, saddr	2	4	$A \leftarrow A \land (saddr)$	×		
	A, !addr16	3	8	$A \leftarrow A \land (addr16)$	×		
	A, [HL]	1	6	$A \leftarrow A \land (HL)$	×		
	A, [HL + byte]	2	6	$A \leftarrow A \land (HL + byte)$	×		

Note Only when rp = BC, DE, or HL.

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Remark The instruction clock cycle is based on the CPU clock (fcPu), specified by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation	z	Flaç AC	g : CY
OR	A, #byte	2	4	$A \leftarrow A \lor byte$	×		
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) \lor byte$	×		
	A, r	2	4	$A \leftarrow A \lor r$	×		
	A, saddr	2	4	$A \leftarrow A \lor (saddr)$	×		
	A, !addr16	3	8	$A \leftarrow A \lor (addr16)$	×		
	A, [HL]	1	6	$A \leftarrow A \lor (HL)$	×		
	A, [HL + byte]	2	6	$A \leftarrow A \lor (HL + byte)$	×		
XOR	A, #byte	2	4	$A \leftarrow A \checkmark byte$	×		
	saddr, #byte	3	6	$(saddr) \leftarrow (saddr) + byte$	×		
	A, r	2	4	$A \leftarrow A \forall r$	×		
	A, saddr	2	4	$A \leftarrow A \checkmark (saddr)$	×		
	A, !addr16	3	8	$A \leftarrow A \forall$ (addr16)	×		
	A, [HL]	1	6	$A \leftarrow A \nleftrightarrow (HL)$	×		
	A, [HL + byte]	2	6	$A \leftarrow A \neq (HL + byte)$	×		
CMP	A, #byte	2	4	A – byte	×	×	×
	saddr, #byte	3	6	(saddr) – byte	×	×	×
	A, r	2	4	A – r	×	×	×
	A, saddr	2	4	A – (saddr)	×	×	×
	A, !addr16	3	8	A – (addr16)	×	×	×
	A, [HL]	1	6	A – (HL)	×	×	×
	A, [HL + byte]	2	6	A – (HL + byte)	×	×	×
ADDW	AX, #word	3	6	AX, CY \leftarrow AX + word	×	×	×
SUBW	AX, #word	3	6	AX, CY \leftarrow AX – word	×	×	×
CMPW	AX, #word	3	6	AX – word	×	×	×
INC	r	2	4	r ← r + 1	×	×	
	saddr	2	4	$(saddr) \leftarrow (saddr) + 1$	×	×	
DEC	r	2	4	r ← r − 1	×	×	
	saddr	2	4	$(saddr) \leftarrow (saddr) - 1$	×	×	
INCW	rp	1	4	$rp \leftarrow rp + 1$			
DECW	rp	1	4	$rp \leftarrow rp - 1$			
ROR	A, 1	1	2	$(CY, A_7 \leftarrow A_0, A_{m-1} \leftarrow A_m) \times 1$			×
ROL	A, 1	1	2	$(CY, A_0 \leftarrow A_7, A_{m+1} \leftarrow A_m) \times 1$			×
RORC	A, 1	1	2	$(CY \leftarrow A_0, A_7 \leftarrow CY, A_{m-1} \leftarrow A_m) \times 1$			×
ROLC	A, 1	1	2	$(CY \leftarrow A_7, A_0 \leftarrow CY, A_{m+1} \leftarrow A_m) \times 1$			×

Remark The instruction clock cycle is based on the CPU clock (fcPU), specified by the processor clock control register (PCC).

Mnemonic	Operand	Byte	Clock	Operation		Flag	
Whetheric	Operand	Byte	Olock		Z	AC	CY
SET1	saddr. bit	3	6	(saddr. bit) \leftarrow 1			
	sfr. bit	3	6	sfr. bit ← 1			
	A. bit	2	4	A. bit $\leftarrow 1$			
	PSW. bit	3	6	PSW. bit $\leftarrow 1$	×	×	×
	[HL]. bit	2	10	(HL). bit \leftarrow 1			
CLR1	saddr. bit	3	6	(saddr. bit) $\leftarrow 0$			
	sfr. bit	3	6	sfr. bit $\leftarrow 0$			
	A. bit	2	4	A. bit $\leftarrow 0$			
	PSW. bit	3	6	PSW. bit $\leftarrow 0$	×	×	×
	[HL]. bit	2	10	(HL). bit $\leftarrow 0$			
SET1	CY	1	2	CY ← 1			1
CLR1	CY	1	2	$CY \leftarrow 0$			0
NOT1	CY	1	2	$CY \leftarrow \overline{CY}$			×
CALL	!addr16	3	6	$(SP - 1) \leftarrow (PC + 3)_{H}, (SP - 2) \leftarrow (PC + 3)_{L},$ $PC \leftarrow addr16, SP \leftarrow SP - 2$			
CALLT	[addr5]	1	8	$(SP - 1) \leftarrow (PC + 1)_{H}, (SP - 2) \leftarrow (PC + 1)_{L},$ $PC_{H} \leftarrow (00000000, addr5 + 1),$ $PC_{L} \leftarrow (00000000, addr5),$ $SP \leftarrow SP - 2$			
RET		1	6	$PC_{H} \leftarrow (SP + 1), PC_{L} \leftarrow (SP),$ $SP \leftarrow SP + 2$			
RETI		1	8	$\begin{array}{l} PC_{H} \leftarrow (SP + 1), PC_{L} \leftarrow (SP), \\ PSW \leftarrow (SP + 2), SP \leftarrow SP + 3, \\ NMIS \leftarrow 0 \end{array}$	R	R	R
PUSH	PSW	1	2	$(SP - 1) \leftarrow PSW, SP \leftarrow SP - 1$			
	rp	1	4	$(SP - 1) \leftarrow rpH, (SP - 2) \leftarrow rpL,$ $SP \leftarrow SP - 2$			
POP	PSW	1	4	$PSW \leftarrow (SP), SP \leftarrow SP + 1$	R	R	R
	rp	1	6	$rpH \leftarrow (SP + 1), rpL \leftarrow (SP),$ $SP \leftarrow SP + 2$			
MOVW	SP, AX	2	8	$SP \leftarrow AX$			
	AX, SP	2	6	$AX \leftarrow SP$			
BR	!addr16	3	6	$PC \leftarrow addr16$			
	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$			
	AX	1	6	$PC_{H} \leftarrow A, PC_{L} \leftarrow X$			

NEC

Remark The instruction clock cycle is based on the CPU clock (fcPu), specified by the processor clock control register (PCC).

Magazia	Onerrend	Dute	Cleak	Or creticer		Flag	J
Mnemonic	Operand	Byte	Clock	Operation	Z	AC	CY
BC	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $CY = 1$			
BNC	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $CY = 0$			
BZ	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $Z = 1$			
BNZ	\$addr16	2	6	$PC \leftarrow PC + 2 + jdisp8$ if $Z = 0$			
BT	saddr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if (saddr. bit) = 1			
	sfr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if sfr. bit = 1			
	A. bit, \$addr16	3	8	$PC \leftarrow PC + 3 + jdisp8$ if A. bit = 1			
	PSW. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if PSW. bit = 1			
BF	saddr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if (saddr. bit) = 0			
	sfr. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if sfr. bit = 0			
	A. bit, \$addr16	3	8	$PC \leftarrow PC + 3 + jdisp8$ if A. bit = 0			
	PSW. bit, \$addr16	4	10	$PC \leftarrow PC + 4 + jdisp8$ if PSW. bit = 0			
DBNZ	B, \$addr16	2	6	$B \leftarrow B - 1$, then PC \leftarrow PC + 2 + jdisp8 if $B \neq 0$			
	C, \$addr16	2	6	$C \leftarrow C - 1$, then PC \leftarrow PC + 2 + jdisp8 if C $\neq 0$			
	saddr, \$addr16	3	8	$(saddr) \leftarrow (saddr) - 1$, then PC \leftarrow PC + 3 + jdisp8 if $(saddr) \neq 0$			
NOP		1	2	No Operation			
EI		3	6	IE \leftarrow 1 (Enable Interrupt)			
DI		3	6	$IE \leftarrow 0$ (Disable Interrupt)			
HALT		1	2	Set HALT Mode			
STOP		1	2	Set STOP Mode			

Remark The instruction clock cycle is based on the CPU clock (fcPu), specified by the processor clock control register (PCC).

7. ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings (T_A = 25°C)

Parameter	Symbol	Conditions	Ratings	Unit
Supply voltage	Vdd		–0.3 to +6.5	V
	Vpp		-0.3 to +10.5	V
Input voltage	Vı		-0.3 to V _{DD} + 0.3	V
Output voltage	Vo		-0.3 to VDD + 0.3	V
Output current, high	Іон	Per pin	-10	mA
		Total for all pins	-30	mA
Output current, low	Iol	Per pin	30	mA
		Total for all pins	160	mA
Operating ambient temperature	TA	In normal operation mode	-40 to +85	°C
		During flash memory programming	10 to 40	°C
Storage temperature	T _{stg}		-40 to +125	°C

- Caution Product quality may suffer if the maximum absolute ratings exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of port pins.

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input capacitance	CIN	f = 1 MHz			15	pF
Output capacitance	Соит	Unmeasured pins returned to			15	pF
Input/output capacitance	Сю	0 V			15	pF

Capacitance (T_A = 25°C, V_{DD} = V_{SS} = 0 V)

Resonator	Recommended Circuit	Parameter	Conditions	MIN.	TYP.	MAX.	Unit
Ceramic resonator	x_1 x_2 $c_1 \leftarrow \Pi \leftarrow c_2$	Oscillation frequency (fx) ^{Note 1}	VDD = Oscillation voltage range	1.0		5.0	MHz
		Oscillation stabilization time ^{Note 2}	After V _{DD} reaches the oscillation voltage range MIN.			4	ms
Crystal resonator		Oscillation frequency (fx) ^{Note 1}		1.0		5.0	MHz
		Oscillation stabilization time ^{Note 2}	V _{DD} = 4.5 to 5.5 V			10	ms
	111					30	
External clock		X1 input frequency (fx) ^{Note 1}		1.0		5.0	MHz
		X1 input high-/low-level width (txH, txL)		85		500	ns
	X1 X2	X1 input frequency (fx) ^{Note 1}	V _{DD} = 2.7 to 5.5 V	1.0		5.0	MHz
		X1 input high-/low-level width (txн, txL)	V _{DD} = 2.7 to 5.5 V	85		500	ns

System Clock Oscillator Characteristics ($T_A = -40^{\circ}C$ to $+85^{\circ}C$, $V_{DD} = 1.8$ to 5.5 V)

Notes 1. Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.

2. Time required to stabilize oscillation after reset or STOP mode release. Use a resonator whose oscillation is stabilized within the oscillation stabilization wait time.

Caution When using the system clock oscillator, wire as follows in the area enclosed by the broken lines in the above figures to avoid an adverse effect from wiring capacitance.

- Keep the wiring length as short as possible.
- Do not cross the wiring with the other signal lines.
- Do not route the wiring near a signal line through which a high fluctuating current flows.
- Always make the ground point of the oscillator capacitor the same potential as Vsso.
- Do not ground the capacitor to a ground pattern through which a high current flows.
- Do not fetch signals from the oscillator.

Parameter	Symbol	Con	ditions		MIN.	TYP.	MAX.	Unit
Output current, high	Іон	Per pin					-1	mA
		Total for all pins					-15	mA
Output current, low	Iol	Per pin					10	mA
		Total for all pins					80	mA
Input voltage, high	VIH1	P00 to P07, P10 to P17,	V _{DD} = 2.7 to 5	5.5 V	0.7Vdd		Vdd	V
		P21, P51 to 53			0.9Vdd		Vdd	V
	VIH2	P20, P22, P30 to P32, P	40 V _{DD} = 2.7 to 5	5.5 V	0.8Vdd		Vdd	V
		to P47, P50, RESET			0.9Vdd		Vdd	V
	Vінз	X1, X2	VDD = 5.0±10	%	Vdd - 0.5		Vdd	V
					Vdd - 0.1		Vdd	V
Input voltage, low	VIL1	P00 to P07, P10 to P17,	VDD = 2.7 to 5	5.5 V	0		0.3Vdd	V
		P21, P51 to P53			0		0.1Vdd	V
	VIL2	P20, P22, P30 to P32, P	40 V _{DD} = 2.7 to 5	5.5 V	0		0.2Vdd	V
		to P47, P50, RESET			0		0.1Vdd	V
	VIL3	X1, X2	VDD = 5.0±10	%	0		0.4	V
					0		0.1	V
Output voltage,	Vон	/bb = 4.5 to 5.5 V, Iон = -1 mA			Vdd - 1.0			V
high		V _{DD} = 1.8 to 5.5 V, Iон = -	′ор = 1.8 to 5.5 V, Іон = –100 µА					V
Output voltage, low	Vol	$V_{DD} = 4.5 \text{ to } 5.5 \text{ V}, \text{ IoL} = 7$	I0 mA				1.0	V
		VDD = 1.8 to 5.5 V, IOL = 4	400 μA				0.5	V
Input leakage	Ілні	VIN = VDD	ins other than X1	and X2			3	μA
current, high	ILIH2	×	1, X2				20	μA
Input leakage		V _{IN} = 0 V F	ins other than X1	and X2			-3	μA
current, low	ILIL2	×	1, X2				-20	μA
Output leakage current, high	LOH	Vout = Vdd					3	μA
Output leakage current, low	ILOL	Vout = 0 V					-3	μA
Software pull-up resistor	R	$V_{IN} = 0 V$			50	100	200	kΩ
Supply current ^{Note 1}		5.0-MHz crystal oscillation	n VDD = 5.0 V±1	10% ^{Note 2}		4.0	15.0	mA
		operating mode (C1 = C2 = 22 pF)	VDD = 3.0 V±1	10% ^{Note 3}		1.0	5.0	mA
		(01 = 02 = 22 pr)	$V_{DD} = 2.0 V \pm 1$	10% ^{Note 3}		0.8	3.0	mA
	DD2	5.0-MHz crystal oscillation	on VDD = 5.0 V±1	10% ^{Note 2}		0.8	5.0	mA
		HALT mode (C1 = C2 = 22 pF)	VDD = 3.0 V±1	10% ^{Note 3}		0.5	2.5	mA
		(01 = 02 = 22 pr)	VDD = 2.0 V±1	10% ^{Note 3}		0.3	1.0	mA
	IDD3	STOP mode	VDD = 5.0 V±1	10%		0.1	30	μA
			VDD = 3.0 V±1	10%		0.05	10	μA
			VDD = 2.0 V±1	10%		0.05	10	μA

DC Characteristics (T_A = -40° C to $+85^{\circ}$ C, V_{DD} = 1.8 to 5.5 V)

Notes 1. The current flowing to the ports (including the current flowing through the on-chip pull-up resistors) is not included.

- 2. High-speed mode operation (when the processor clock control register (PCC) is set to 00H)
- 3. Low-speed mode operation (when PCC is set to 02H)

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of port pins.

Flash Memory Write/Delete Characteristics

$(T_{A} = 10 \text{ to})$	40°C. Vpp = 1.8 to	o 5.5 V, in 5.0-MHz o	rystal oscillation o	peration mode)
(1 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10 0 - 10		5.5 v , in 5.0-ivi iz c	i yətai üsematleri ü	peration mode

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Write current ^{∾ee} (V _{DD} pin)	DDW	When VPP supply voltage = VPP1			18	mA
Write current ^{∾te} (Vpp pin)	IPPW	When VPP supply voltage = VPP1			22.5	mA
Delete current ^{Note} (Vdd pin)	Idde	When VPP supply voltage = VPP1			18	mA
Delete current ^{Note} (VPP pin)	IPPE	When VPP supply voltage = VPP1			115	mA
Unit delete time	ter		0.5	1	1	S
Total delete time	tera				20	S
Write count		Delete/write are regarded as 1 cycle	20	20	20	Times
VPP supply voltage	VPP0	In normal operation	0		0.2Vdd	V
	Vpp1	During flash memory programming	9.7	10.0	10.3	V

Note The current flowing to the ports (including the current flowing through the on-chip pull-up resistors) is not included.

AC Characteristics

(1) Basic operation ($T_A = -40^{\circ}C$ to $+85^{\circ}C$, $V_{DD} = 1.8$ to 5.5 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Cycle time	Тсү	V _{DD} = 2.7 to 5.5 V	0.4		8	μs
(minimum instruction execution time)			1.6		8	μs
TI0 input high-/low-	t⊤ıн, t⊤ı∟	V _{DD} = 2.7 to 5.5 V	0.1			μs
level width			1.8			μs
TI0 input frequency	fтı	V _{DD} = 2.7 to 5.5 V	0		4	MHz
			0		275	kHz
Interrupt input high-/low-level width	tinth, tintl	INTP0 to INTP2	10			μs
RESET low-level width	trsl		10			μs

Tcy vs VDD (system clock)



(2) Serial interface 00 ($T_A = -40^{\circ}C$ to $+85^{\circ}C$, $V_{DD} = 1.8$ to 5.5 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
SCK0 cycle time	tKCY1	VDD = 2.7 to 5.5 V		800			ns
				3200			ns
SCK0 high-/low- level width	tĸнı, tĸ∟ı	V _{DD} = 2.7 to 5.5 V		tксү1/2 – 50			ns
				tkcy1/2 – 150			ns
SI0 setup time	tsıkı	VDD = 2.7 to 5.5 V		150			ns
(to SCK0↑)				500			ns
SI0 hold time (from $\overline{SCK0}$)	tksi1	V _{DD} = 2.7 to 5.5 V		400			ns
				600			ns
SO0 output delay time from $\overline{SCK0}\downarrow$	tkso1	tκso1 $R = 1 k\Omega, C = 100 pF^{Note}$	V _{DD} = 2.7 to 5.5 V	0		250	ns
				0		1000	ns

(i) 3-wire serial I/O mode (SCK0...Internal clock output)

Note R and C are the load resistance and load capacitance of the SO0 output line, respectively.

(ii) 3-wire serial I/O mode (SCK0...External clock input)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
SCK0 cycle time	tксү2	V _{DD} = 2.7 to 5.5 V		900			ns
				3500			ns
SCK0 high-/low-	tĸн₂, tĸ∟₂	V _{DD} = 2.7 to 5.5 V		400			ns
level width				1600			ns
SI0 setup time (to	tsik2	VDD = 2.7 to 5.5 V		100			ns
SCK0↑)				150			ns
SI0 hold time (from	tksi2	VDD = 2.7 to 5.5 V		400			ns
SCK0↑)				600			ns
SO0 outpu <u>t delay</u> time from SCK0↓	tkso2	$R = 1 \text{ k}\Omega$, $C = 100 \text{ pF}^{\text{Note}}$	V _{DD} = 2.7 to 5.5 V	0		300	ns
ume nom SCK0↓				0		1000	ns

Note R and C are the load resistance and load capacitance of the SO0 output line, respectively.

(iii) UART mode (Dedicated baud rate generator output)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		V _{DD} = 2.7 to 5.5 V			78125	bps
					19531	bps

(iv) UART mode (External clock input)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
ASCK cycle time	tксүз	V _{DD} = 2.7 to 5.5 V	900			ns
			3500			ns
ASCK high-/low-	tкнз, tк∟з	V _{DD} = 2.7 to 5.5 V	400			ns
level width			1600			ns
Transfer rate		VDD = 2.7 to 5.5 V			39063	bps
					9766	bps
ASCK rise/fall time	tr, tr				1	μs

AC Timing Test Points (Except the X1 input)



Clock Timing



TI Timing



Interrupt Input Timing



RESET Input Timing



Serial Transfer Timing

3-wire serial I/O mode:



m = 1, 2

UART mode (External clock input):



Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	Vdddr		1.8		5.5	V
Release signal set time	tsrel		0			μs
Oscillation	t wait	Release by RESET		215/fx		ms
stabilization wait time		Release by interrupt		Note		ms

Data Memory Stop Mode Low Supply Voltage Data Retention Characteristics (T_A = -40°C to +85°C)

Note 2¹²/fx, 2¹⁵/fx, or 2¹⁷/fx can be selected according to the setting of bits 0 to 2 (OSTS0 to OSTS2) of the oscillation stabilization time selection register.

Remark fx: System clock oscillation frequency

Data Retention Timing (STOP mode release by RESET)



Data Retention Timing (Standby release signal: STOP mode release by interrupt signal)



8. PACKAGE DRAWINGS

42PIN PLASTIC SHRINK DIP (600 mil)



NOTES

- 1) Each lead centerline is located within 0.17 mm (0.007 inch) of its true position (T.P.) at maximum material condition.
- 2) Item "K" to center of leads when formed parallel.

ITEM	MILLIMETERS	INCHES
Α	39.13 MAX.	1.541 MAX.
В	1.78 MAX.	0.070 MAX.
С	1.778 (T.P.)	0.070 (T.P.)
D	0.50±0.10	$0.020^{+0.004}_{-0.005}$
F	0.9 MIN.	0.035 MIN.
G	3.2±0.3	0.126±0.012
Н	0.51 MIN.	0.020 MIN.
I	4.31 MAX.	0.170 MAX.
J	5.08 MAX.	0.200 MAX.
К	15.24 (T.P.)	0.600 (T.P.)
L	13.2	0.520
М	$0.25^{+0.10}_{-0.05}$	$0.010^{+0.004}_{-0.003}$
N	0.17	0.007
R	0~15°	0~15°
		P42C-70-600A-1

44 PIN PLASTIC QFP (□10)



detail of lead end



ITEM	MILLIMETERS	INCHES
А	13.2±0.2	$0.520^{+0.008}_{-0.009}$
В	10.0±0.2	$0.394^{+0.008}_{-0.009}$
С	10.0±0.2	$0.394^{+0.008}_{-0.009}$
D	13.2±0.2	$0.520^{+0.008}_{-0.009}$
F	1.0	0.039
G	1.0	0.039
н	$0.37^{+0.08}_{-0.07}$	$0.015^{+0.003}_{-0.004}$
I	0.16	0.007
J	0.8 (T.P.)	0.031 (T.P.)
К	1.6±0.2	0.063±0.008
L	0.8±0.2	0.031+0.009 -0.008
М	$0.17 \substack{+0.06 \\ -0.05}$	$0.007^{+0.002}_{-0.003}$
N	0.10	0.004
Р	2.7±0.1	$0.106^{+0.005}_{-0.004}$
Q	0.125±0.075	0.005±0.003
R	3°+7° -3°	3° ^{+7°} -3°
S	3.0 MAX.	0.119 MAX.
		S44GB-80-3BS-1

NOTE

- 1. Controlling dimension millimeter.
- 2. Each lead centerline is located within 0.16 mm (0.007 inch) of its true position (T.P.) at maximum material condition.
44 PIN PLASTIC LQFP (10x10)



NOTE

Each lead centerline is located within 0.16 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	
Α	12.0±0.2	
В	10.0±0.2	
С	10.0±0.2	
D	12.0±0.2	
F	1.0	
G	1.0	
Н	$0.37^{+0.08}_{-0.07}$	
I	0.2	
J	0.8 (T.P.)	
К	1.0±0.2	
L	0.5	
М	$0.17^{+0.03}_{-0.06}$	
N	0.10	
Р	1.4±0.05	
Q	0.1±0.05	
R	$3^{\circ}^{+4^{\circ}}_{-3^{\circ}}$	
S	1.6 MAX.	
U	0.6±0.15	
	S44GB-80-8ES-1	

9. RECOMMENDED SOLDERING CONDITIONS

The μ PD78F9026A should be soldered and mounted under the following recommended conditions.

For the details of the recommended soldering conditions, refer to the document **Semiconductor Device Mounting Technology Manual (C10535E)**.

For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

Table 9-1. Surface Mounting Type Soldering Conditions

μ PD78F9026AGB-3BS-MTX: 44-pin plastic QFP (10 × 10 mm, resin thickness 2.7 mm)

Soldering Method	Soldering Conditions	Recommended Condition Symbol	
Infrared reflow	Package peak temperature: 235°C, Time: 30 sec. Max. (at 210°C or higher), Count: three times or less	IR35-00-3	
VPS	Package peak temperature: 215°C, Time: 40 sec. Max. (at 200°C or higher), Count: three times or less	VP15-00-3	
Wave soldering	Solder bath temperature: 260°C Max., Time: 10 sec. Max., Count: Once, Preheating temperature: 120°C Max. (package surface temperature)	WS60-00-1	
Partial heating	Pin temperature: 300°C Max. Time: 3 sec. Max. (per pin row)	_	

Caution Do not use different soldering methods together (except for partial heating).

μ PD78F9026AGB-8ES: 44-pin plastic LQFP (10 × 10 mm, resin thickness 1.4 mm)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 sec. Max. (at 210°C or higher), Count: twice or less	IR35-00-2
VPS	Package peak temperature: 215°C, Time: 40 sec. Max. (at 200°C or higher), Count: twice or less	VP15-00-2
Wave soldering	Solder bath temperature: 260°C Max., Time: 10 sec. Max., Count: Once, Preheating temperature: 120°C Max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C Max. Time: 3 sec. Max. (per pin row)	—

Caution Do not use different soldering methods together (except for partial heating).

Table 9-2. Insertion Type Soldering Conditions

μPD78F9026ACU: 42-pin plastic shrink DIP (600 mils)

Soldering Method	Soldering Conditions	
Wave soldering (pin only)	Solder bath temperature: 260°C Max., Time: 10 sec. Max.	
Partial heating	Pin temperature: 300°C Max., Time: 3 sec. Max. (for each pin)	

Caution Apply wave soldering only to the pins and be careful not to bring solder into direct contact with the package.

APPENDIX A DIFFERENCES BETWEEN μ PD78F9026A AND MASK ROM VERSIONS

The μ PD78F9026A has flash memory in place of the internal ROM of the mask ROM versions (μ PD789022, 789024, 789025, and 789026). Differences between the μ PD78F9026A and mask ROM versions are shown in Table A-1.

Parameter		Flash Memory Version	Mask ROM Versions			
		μPD78F9026A	μPD789022	μPD789024	μPD789025	μPD789026
Internal	ROM structure	Flash memory	Mask ROM			
memory	ROM capacity	16 Kbytes	4 Kbytes	8 Kbytes	12 Kbytes	16 Kbytes
	High-speed RAM capacity	512 bytes	256 bytes		512 bytes	
V _{PP} pin		Available	Not available			
IC pin		Not available	ailable Available			
Electrical spe	ecifications	See the relevant data she	sheet			

Table A-1. Differences between µPD78F9026A and Mask ROM Versions

Caution There are differences in noise immunity and noise radiation between the flash memory and mask ROM versions. When pre-producing an application set with the flash memory version and then mass-producing it with the mask ROM version, be sure to conduct sufficient evaluations for the consumer samples (not engineering samples) of the mask ROM version.

APPENDIX B DEVELOPMENT TOOLS

The following development tools are available for system development using the μ PD78F9026A.

Language Processing Software

RA78K0S ^{Notes 1, 2, 3}	Assembler package common to 78K/0S Series	
CC78K0S ^{Notes 1, 2, 3}	C compiler package common to 78K/0S Series	
DF789026 ^{Notes 1, 2, 3}	Device file for the μ PD789026 Subseries	
CC78K0S-L ^{Notes 1, 2, 3}	C compiler library source file common to 78K/0S Series	

Flash Memory Writing Tools

Flashpro III (FL-PR3 ^{№™ 4} , PG-FP3)	Dedicated flash programmer for microcontrollers incorporating flash memory
FA-42CU ^{Note 4}	Flash memory writing adapter for 42-pin plastic shrink DIP (CU type)
FA-44GB ^{Note 4}	Flash memory writing adapter for 44-pin plastic QFP (GB-3BS type)
FA-44GB-8ES ^{Note 4}	Flash memory writing adapter for 44-pin plastic LQFP (GB-8ES type)

Debugging Tools

IE-78K0S-NS In-circuit emulator	In-circuit emulator for debugging the hardware and software of the application system using the 78K/0S series. Supports the integrated debugger (ID78K0S-NS). Used with an AC adapter, emulation probe, and interface adapter that connects the host machine.
IE-70000-MC-PS-B AC adapter	Adapter that distributes power supply from an AC100 to 240-V outlet.
IE-70000-98-IF-C Interface adapter	Adapter when using a PC-9800 series PC (except notebook type) as the host machine of the IE-78K0S-NS (C bus supported).
IE-70000-CD-IF-A PC card interface	PC card and interface cable when using a notebook type PC as the host machine of the IE- 78K0S-NS (PCMCIA socket supported).
IE-70000-PC-IF-C Interface adapter	Adapter when using an IBM PC/AT [™] or compatible as the host machine of the IE-78K0S-NS (ISA bus supported).
IE-70000-PCI-IF Interface adapter	Adapter when using a PC with PCI bus as the host machine of the IE-78K0S-NS.
IE-789026-NS-EM1 Emulation board	Board for emulating device-specific peripheral hardware. Used with an in-circuit emulator.
NP-42CU ^{Note 4}	Board connecting an in-circuit emulator and target system. For 42-pin plastic shrink DIP (CU type).
NP-44GB ^{Note 4} NP-44GB-TQ ^{Note 4}	Board connecting an in-circuit emulator and target system. For 44-pin plastic QFP (GB-3BS type) and 44-pin plastic LQFP (GB-8ES type).
SM78K0S ^{Notes 1,2}	System simulator common to 78K/0S Series
ID78K0S-NS ^{Notes 1,2}	Integrated debugger common to 78K/0S Series
DF789026 ^{Notes 1,2}	Device file for μ PD789026 Subseries

Real-Time OS

MX78K0S ^{Notes 1, 2} OS for 78K/0S Series

Notes 1. Based on the PC-9800 series (MS-DOS[™] + Windows[™])

- 2. Based on the IBM PC/AT and compatibles (Japanese/English Windows)
- **3.** Based on the HP9000 series 700[™] (HP-UX[™]), SPARCstation[™] (SunOS[™], Solaris[™]), and NEWS[™] (NEWS-OS[™])
- 4. Products manufactured by Naito Densei Machida Mfg. Co., Ltd. (+81-44-822-3813).

Remark The RA78K0S, CC78K0S, and SM78K0S can be used in combination with the DF789026.

APPENDIX C RELATED DOCUMENTS

Documents Related to Devices

Document Name	Document No.	
	English Japanese	
μPD789022, 789024, 789025, 789026 Data Sheet	U11715E	U11715J
μ PD78F9026A Data Sheet	This manual	U14356J
μ PD789026 Subseries User's Manual	U11919E	U11919J
78K/0S Series User's Manual — Instruction	U11047E	U11047J

Documents Related to Development Tools (User's Manuals)

Document Name		Document No.		
		English	Japanese	
RA78K0S Assembler Package	Operation	U11622E	U11622J	
	Assembly Language	U11599E	U11599J	
	Structured Assembly Language	U11623E	U11623J	
CC78K/0S C Compiler	Operation	U11816E	U11816J	
	Language	U11817E	U11817J	
SM78K0S System Simulator Windows Based	Reference	U11489E	U11489J	
SM78K Series System Simulator	External Parts User Open Interface Specifications	U10092E	U10092J	
ID78K0S-NS Integrated Debugger Windows Based	Reference	U12901E	U12901J	
IE-78K0S-NS In-Circuit Emulator		U13549E	U13549J	
IE-789026-NS-EM1 Emulation Board		To be prepared	To be prepared	

Documents Related to Embedded Software (User's Manual)

Document Name	Document No.	
	English	Japanese
78K/0S Series OS MX78K0S	U12938E	U12938J

Caution The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

Other Related Documents

Document Name	Document No.	
	English	Japanese
SEMICONDUCTOR SELECTION GUIDE Products & Packages (CD-ROM)	X13769X	
Semiconductor Device Mounting Technology Manual	C10535E	C10535J
Quality Grades on NEC Semiconductor Device	C11531E	C11531J
NEC Semiconductor Device Reliability/Quality Control System	C10983E	C10983J
Guide to Prevent Damage for Semiconductor Devices by Electrostatic Discharge (ESD)	C11892E	C11892J
Guide to Microcomputer-Related Products by Third Party	_	U11416J

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[MEMO]

NOTES FOR CMOS DEVICES

① PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

② HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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